

Notice of References Cited

Application/Control No.

10/694,730

Applicant(s)/Patent Under
Reexamination
TRAN ET AL.

Examiner

Steven D. Radosevich

Art Unit

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U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------------|----------------|
| * | A | US-6,880,078 | 04-2005 | Rabinovich, Ricardo O. | 713/100 |
| * | B | US-6,859,825 | 02-2005 | Williams, Robert | 709/220 |
| * | C | US-7,080,162 | 07-2006 | Conley et al. | 709/250 |
| * | D | US-7,133,416 | 11-2006 | Chamdani et al. | 370/466 |
| * | E | US-2002/0019173 | 02-2002 | Oliphant et al. | 439/676 |
| * | F | US-2002/0165924 | 11-2002 | Kim et al. | 709/209 |
| * | G | US-2001/0009553 | 07-2001 | Homann, Magnus | 370/445 |
| * | H | US-2002/0157030 | 10-2002 | Barker et al. | 713/320 |
| * | I | US-2001/0043603 | 11-2001 | Yu, Shaohua | 370/393 |
| * | J | US-6,789,144 | 09-2004 | Lai et al. | 710/57 |
| * | K | US-6,434,157 | 08-2002 | Dube' et al. | 370/401 |
| * | L | US-6,183,307 | 02-2001 | Laity et al. | 439/676 |
| * | M | US-5,803,757 | 09-1998 | Wang, Tsan-Chi | 439/188 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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| | P | | | | | |
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| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|--|
| | U | The institute of Electrical and Electronics Engineering, Inc (IEEE); IEEE 100 The Authoritative Dictionary of IEEE standards terms, Dec. 2000; Standards Information Network IEEE Press; Seventh Edition; p. 1196. |
| | V | EtherLink III ISA Network Interface Card User Guide; Jan 1998; pages 1-110;. |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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2117

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U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| * | A | US-2002/0019173 | 02-2002 | Oliphant et al. | 439/676 |
| * | B | US-2001/0000161 | 04-2001 | Laity, Ian A. | 439/676 |
| * | C | US-6,760,781 | 07-2004 | Wang et al. | 709/250 |
| * | D | US-5,660,568 | 08-1997 | Moshayedi, Mark | 439/654 |
| * | E | US-6,175,556 | 01-2001 | Allen et al. | 370/293 |
| * | F | US-5,999,021 | 12-1999 | Jang, Hyun-soon | 327/97 |
| * | G | US-6,087,851 | 07-2000 | Kim et al. | 326/63 |
| * | H | US-2004/0068593 | 04-2004 | Helenic et al. | 710/071 |
| * | I | US-6,172,524 | 01-2001 | Cho, Kyu Seok | 326/70 |
| * | J | US-6,516,352 | 02-2003 | Booth et al. | 709/250 |
| * | K | US-6,346,827 | 02-2002 | Yeung et al. | 326/41 |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
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NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
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| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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